

**Search Notes**

Application/Control No.

10/710,693

Examiner

Phallaka Kik

Applicant(s)/Patent under  
Reexamination

BHOOSHAN ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	5,9,10	6/12/2006	PK
Above	updated	1/11/2007	PK
Above	updated	6/3/2007	PK
Above	updated	8/23/2007	PK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	5,9,10	8/23/2007	PK
--USPGPUB (see attached)		8/23/2007	PK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Cls/Sub searched: 716/1-18 (see attached)	6/12/2006	PK
Above updated search (see attached)	1/11/2007	PK
Above updated search (see attached)	6/3/2007	PK
Above updated search (see attached)	8/23/2007	PK
IEE/IEEE Xplore (see attached)	6/12/2006	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	6/12/2006	PK